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# 捷多邦,专业PCB打样工厂,24小时加急出货TNETA1622 622.08-MHz CLOCK-RECOVERY DEVICE

SDNS017C - FEBRUARY 1994 - REVISED DECEMBER 1995

- Recovers a 622.08-MHz Clock Signal From a 622.08-Mbit/s STS-12/STM-4 NRZ Data Stream
- Accepts Pseudo-ECL (PECL) Input Voltage Levels on the Input Data Stream
- Requires a Single 5-V Supply
- Provides PECL-Clock and PECL-Data Outputs

#### description

The TNETA1622 recovers an embedded clock signal from a 622.08-Mbit/s STS-12/STM-4 nonreturn-to-zero (NRZ) data stream using a frequency/phase-locked loop. The device accepts PECL (ECL signals referenced to 5 V instead of GND) input-voltage levels. The recovered clock and data outputs are PECL compatible. The serial data input and recovered clock and data outputs are differential to provide maximum noise immunity.



NC - No internal connection

The TNETA1622 requires only a positive 5-V supply (5 V  $\pm$  5%) for operation. The TNETA1622 is characterized for operation over a temperature range of  $-40^{\circ}$ C to 85°C.

### functional block diagram



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PRODUCT PREVIEW

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TERMINAL		1/0	DESCRIPTION		
NAME	NO.	1/0	DESCRIPTION		
CAPOUTN CAPOUTP	9 10	I	Capacitor connection for phase-locked-loop filter		
CLKOUT CLKOUT	13 14	0	Recovered clock output, PECL compatible		
DATAIN DATAIN	5 6	I	Serial data input, PECL compatible		
DATAOUT DATAOUT	17 18	0	Serial data output, PECL compatible		
GND	4, 7, 11, 12, 19, 20		Ground (0-V reference)		
VCC	1, 2, 8, 15, 16		Supply voltage		
NC	3		No connection. Leave floating (open).		

### **Terminal Functions**

### absolute maximum ratings over operating free-air temperature range (unless otherwise noted)<sup>†</sup>

Supply voltage range, V <sub>CC</sub> (see Note 1)	$\ldots$ $-0.5$ V to 7 V
Input voltage range, V <sub>I</sub> , PECL	
Power dissipation	
Operating free-air temperature range, TA	-40°C to 85°C
Storage temperature range, Tstg	−65°C to 150°C

<sup>†</sup> Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

NOTE 1: All voltage values are with respect to the GND terminals.

## recommended operating conditions

			MIN	NOM	MAX	UNIT
VCC	Supply voltage		4.75	5	5.25	V
VIH	High-level input voltage	PECL (see Note 2)	V <sub>CC</sub> -1.15	-	V <sub>CC</sub> -0.80	V
VIL	Low-level input voltage	PECL (see Note 2)	V <sub>CC</sub> -1.90		V <sub>CC</sub> -1.50	V
TA	Operating free-air temperature		- 40		85	°C

NOTE 2: The algebraic convention, in which the least positive (most negative) value is designated minimum, is used in this data sheet for logic-level voltages only.



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### electrical characteristics over recommended ranges of operating free-air temperature and supply voltage (unless otherwise noted) (see Figure 1)

PARAMETER			TEST CONDITIONS	MIN	TYP MAX	UNIT
∨он	High-level output voltage	<u>DATAOUT,</u> DATAOUT	$V_{CC} = 4.75 V$ to 5.25 V, See Notes 2 and 3	V <sub>CC</sub> -1.03 V <sub>CC</sub> -0.85		V
V <sub>OL</sub>	Low-level output voltage	<u>DATAOUT,</u> DATAOUT	$V_{CC}$ = 4.75 V to 5.25 V, See Notes 2 and 3	V <sub>CC</sub> -1.85	V	
∨он	High-level output voltage	<u>CLKOUT,</u> CLKOUT	$V_{CC} = 5 V$	N	V	
VOL	Low-level output voltage	<u>CLKOUT,</u> CLKOUT	$V_{CC} = 5 V$	N	V	
V <sub>O(PP)</sub>	Output voltage swing, PECL	<u>CLKOUT,</u> CLKOUT	V <sub>CC</sub> = 4.75 V to 5.25 V, See Note 3	400		mV
Ιн	High-level input current	<u>DATAIN,</u> DATAIN	$V_{CC} = 5.25 \text{ V}, \qquad V_{I} = 4.45 \text{ V}$			μΑ
١	Low-level input current	<u>DATAIN,</u> DATAIN	$V_{CC} = 5.25 \text{ V}, \qquad V_{I} = 3.35 \text{ V}$			μΑ
	Supply current		$V_{CC}$ = 5.25 V, f = 622.08 Mbit/s, Outputs open	107		~^^
			V <sub>CC</sub> = 5.25 V, f = 622.08 Mbit/s, See Note 4	107		mA

NOTES: 2. The algebraic convention, in which the least positive (most negative) value is designated minimum, is used in this data sheet for logic-level voltages only.

3. PECL outputs are terminated through a 50- $\Omega$  resistor to V<sub>CC</sub> –2 V.

4. CLKOUT, CLKOUT, DATAOUT, and DATAOUT each are terminated with a 50- $\Omega$  resistor to V<sub>CC</sub> -2 V.

#### operating characteristics over recommended operating free-air temperature range (unless otherwise noted) (see Figure 1)

PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
Acquisition time	See Note 5				ms
Deviation of clock-sampling point, t <sub>CSP</sub>	See Figure 1				ps
RMS jitter, recovered clock	See Note 6				ps
Peak-to-peak jitter, recovered clock					ps
Input data rate		(	622.08		Mbit/s
Duty cycle, recovered clock	See Note 3	45%		55%	
Maximum number of consecutive bits (1 or 0) in input data stream	See Note 7				

NOTES: 3. PECL outputs are terminated through a 50- $\Omega$  resistor to V<sub>CC</sub> – 2 V.

Acquisition time is the time required to achieve a valid clock output while applying a 2<sup>7</sup> - 1 pseudo-random bit sequence.
RMS jitter is measured with a 2<sup>31</sup> - 1 pseudo-random bit sequence.

7. This measurement is made with a  $2^{13} - 1$  pseudo-random bit sequence with string substitution.



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VOLTAGE WAVEFORMS

Figure 1. Load Circuit and Voltage Waveforms



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